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MOSFET – Single N-Channel, SUPERFET[®] III, FRFET[®] **650 V, 75 A, 27.4 m** Ω

NVH4L027N65S3F

Features

- Ultra Low Gate Charge & Low Effective Output Capacitance
- Lower FOM (R_{DS(on) max.} x Q_{g typ.} & R_{DS(on) max.} x E_{OSS})
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	650	٧
Gate-to-Source Voltage - DC	V_{GSS}	±30	V
Gate-to-Source Voltage - AC (f > 1 Hz)	V_{GSS}	±30	V
Drain Current – Continuous (T _C = 25°C)	I _D	75	Α
Drain Current – Continuous (T _C = 100°C)	I _D	60	Α
Drain Current – Pulsed (Note 3)	I _{DM}	187.5	Α
Power Dissipation $(T_C = 25^{\circ}C)$	P_{D}	595	W
Power Dissipation – Derate Above 25°C	P_{D}	4.76	W/°C
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C
Single Pulsed Avalanche Energy (Note 4)	E _{AS}	1610	mJ
Repetitive Avalanche Energy (Note 3)	E _{AR}	5.95	mJ
MOSFET dv/dt	dv/dt	100	V/ns
Peak Diode Recovery dv/dt (Note 5)	dv/dt	50	V/ns
Max. Lead Temperature for Soldering Purposes (1/8" from case for 5 s)	T _L	300	°C

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case, Max. (Notes 1, 2)	$R_{\theta JC}$	0.21	°C/W
Thermal Resistance, Junction-to-Ambient, Max. (Notes 1, 2)	$R_{\theta JA}$	40	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

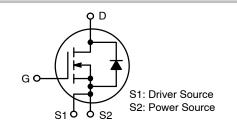
- 1. The entire application environment impacts the thermal resistance values shown. They are not constants and are only valid for the particular conditions noted.
- 2. Assembled to an infinite heatsink with perfect heat transfer from the case (assumes 0 K/W thermal interface).
- 3. Repetitive rating: pulse-width limited by maximum junction temperature.
- 4. I_{AS} = 15 A, R_{G} = 25 Ω , starting T_{J} = 25°C. 5. I_{SD} ≤ 37.5 A, di/dt ≤ 200 A/ μ s, V_{DD} ≤ 400 V, starting T_{J} = 25°C.



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V _{DSS}	R _{DS(ON)} MAX	I _D MAX
650 V	27.4 mΩ @ 10 V	75 A



POWER MOSFET

MARKING DIAGRAM



TO-247-4LD CASE 340CJ



\$Y	= ON Semiconductor Logo
&Z	= Assembly Plant Code
&3	= Data Code (Year & Week)

= Lot

NVH4L027N65S3F = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
NVH4L027N65S3F	TO-247-4LD (Pb-Free)	30 Units / Tube

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	BV _{DSS}	$V_{GS} = 0 \text{ V, } I_D = 1 \text{ mA, } T_J = 25^{\circ}\text{C}$	650			V
Drain-to-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0 V, I _D = 10 mA, T _J = 150°C	700			V
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS} / \Delta T_{J}$	I _D = 20 mA, Referenced to 25°C		610		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 650 V			10	μΑ
		V _{DS} = 520 V, T _C = 125°C		590		
Gate-to-Body Leakage Current	I _{GSS}	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
ON CHARACTERISTICS					·	•
Gate Threshold Voltage	V _{GS(th)}	$V_{GS} = V_{DS}$, $I_D = 3 \text{ mA}$	3.0		5.0	V
Threshold Temperature Coefficient	$\Delta V_{GS(th)}/\Delta T_{J}$	$V_{GS} = V_{DS}$, $I_D = 3 \text{ mA}$		-7.3		mV/°C
Static Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 35 A		21.5	27.4	mΩ
Forward Transconductance	9FS	V _{DS} = 20 V, I _D = 37.5 A		57		S
DYNAMIC CHARACTERISTICS	-			<u>!</u>	<u> </u>	
Input Capacitance	C _{iss}			7780		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 400 V, f = 1 MHz		200		1
Reverse Transfer Capacitance	C _{rss}			26		1
Effective Output Capacitance	C _{oss(eff.)}	V _{DS} = 0 V to 400 V, V _{GS} = 0 V		1880		pF
Energy Related Output Capacitance	C _{oss(er.)}	V _{DS} = 0 V to 400 V, V _{GS} = 0 V		347		pF
Total Gate Charge at 10 V	Q _{G(TOT)}			227		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 400 V, I _D = 37.5 A		35		1
Gate-to-Source Gate Charge	Q _{GS}	(Note 6)		67		1
Gate-to-Drain "Miller" Charge	Q_{GD}			87		
Equivalent Series Resistance	ESR	f = 1 MHz		2.2		Ω
SWITCHING CHARACTERISTICS				1	I.	
Turn-On Delay Time	t _{d(on)}			42		ns
Turn-On Rise Time	t _r	$V_{GS} = 10 \text{ V}, V_{DD} = 400 \text{ V},$		34		ns
Turn-Off Delay Time	t _{d(off)}	$I_D = 37.5 \text{ A}, R_g = 2 \Omega$ (Note 6)		153		ns
Turn-Off Fall Time	t _f	,		18		ns
SOURCE-DRAIN DIODE CHARACTER	ISTICS			1	·	•
Maximum Continuous Source-to- Drain Diode Forward Current	Is	V _{GS} = 0 V			75	А
Maximum Pulsed Source-to-Drain Diode Forward Current	I _{SM}	V _{GS} = 0 V			187.5	А
Source-to-Drain Diode Forward Voltage	V_{SD}	V _{GS} = 0 V, I _{SD} = 37.5 A			1.3	V
Reverse Recovery Time	t _{rr}			171		ns
Charge Time	ta	V _{GS} = 0 V, dI _F /dt = 100 A/μs,		141		1
Discharge Time	t _b	I _{SD} = 37.5 A		29		1
Reverse Recovery Charge	Q _{rr}			973		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Essentially independent of operating temperature typical characteristics.

TYPICAL CHARACTERISTICS

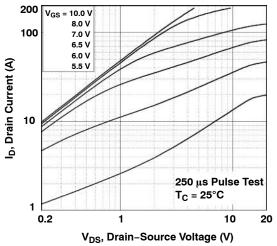


Figure 1. On-Region Characteristics

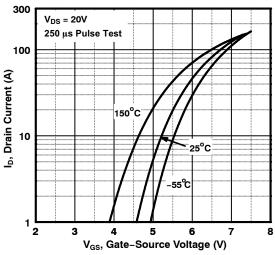


Figure 3. Transfer Characteristics

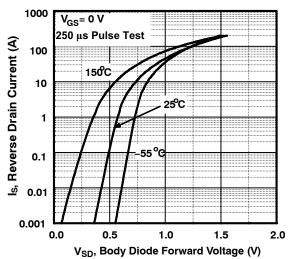


Figure 5. Body Diode Forward Voltage Variation vs. Source Current and Temperature

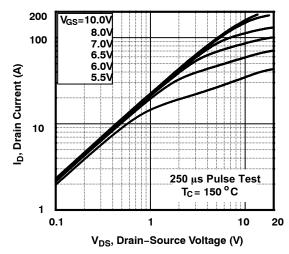


Figure 2. On-Region Characteristics

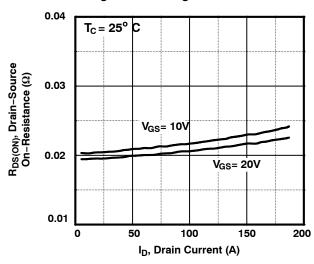


Figure 4. On-Resistance Variation vs. Drain Current and Gate Voltage

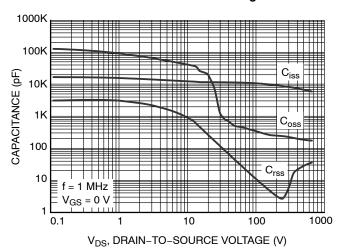


Figure 6. Capacitance Characteristics

TYPICAL CHARACTERISTICS

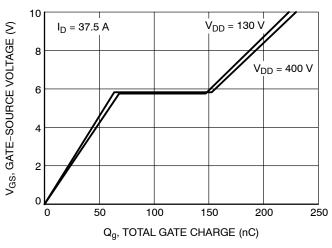


Figure 7. Gate Charge Characteristics

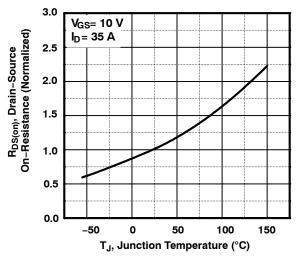
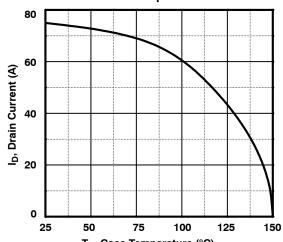


Figure 9. On-Resistance Variation vs. Temperature



T_C, Case Temperature (°C)
Figure 11. Maximum Drain Current vs. Case
Temperature

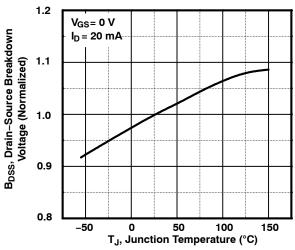


Figure 8. Breakdown Voltage Variation vs. Temperature

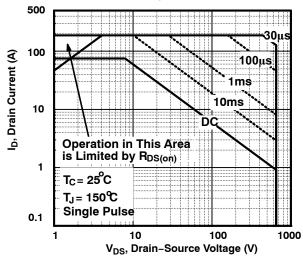
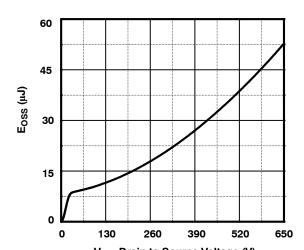


Figure 10. Maximum Safe Operating Area



 $V_{DS},$ Drain to Source Voltage (V) Figure 12. EOSS vs. Drain-to-Source Voltage

TYPICAL CHARACTERISTICS

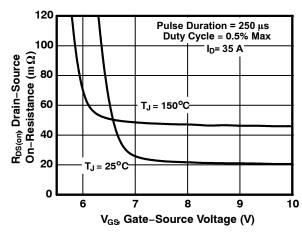


Figure 13. RDSON vs. Gate Voltage

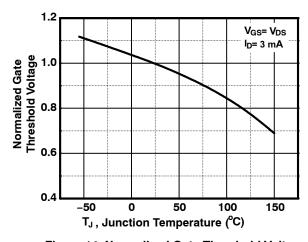
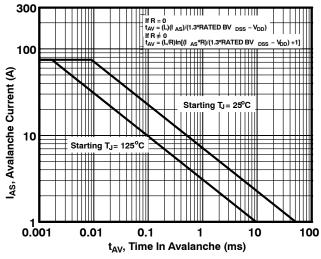


Figure 14. Normalized Gate Threshold Voltage vs. Temperature



NOTE: Refer to Fairchild Application Notes AN7514 and AN7515

Figure 15. Unclamped Inductive Switching Capability

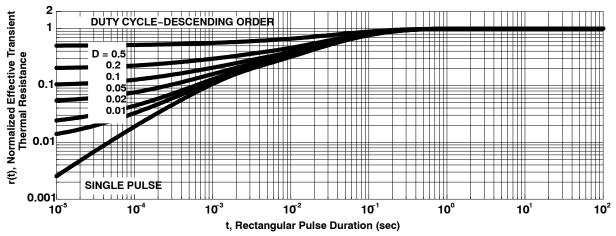


Figure 16. Transient Thermal Response Curve

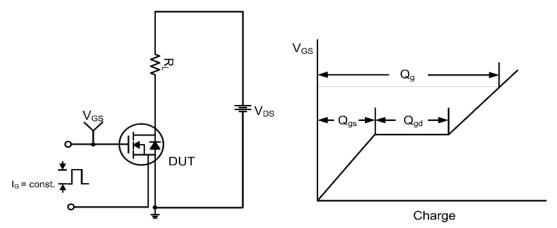


Figure 17. Gate Charge Test Circuit & Waveform

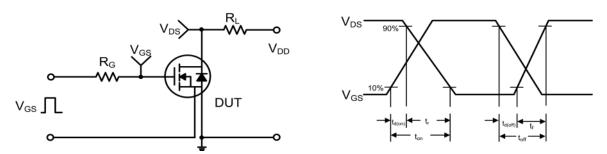


Figure 18. Resistive Switching Test Circuit & Waveforms

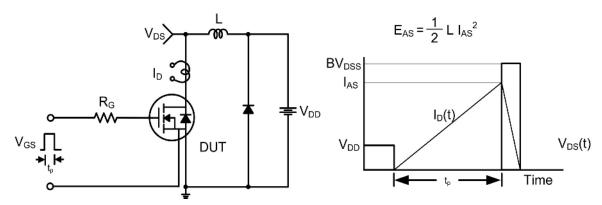


Figure 19. Unclamped Inductive Switching Test Circuit & Waveforms

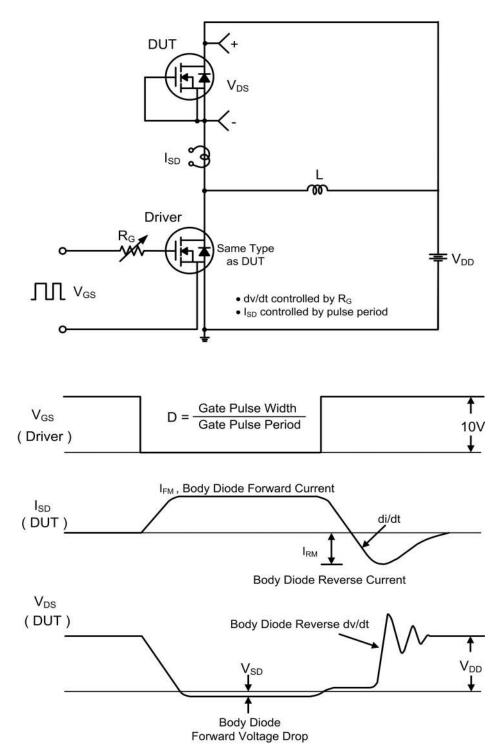
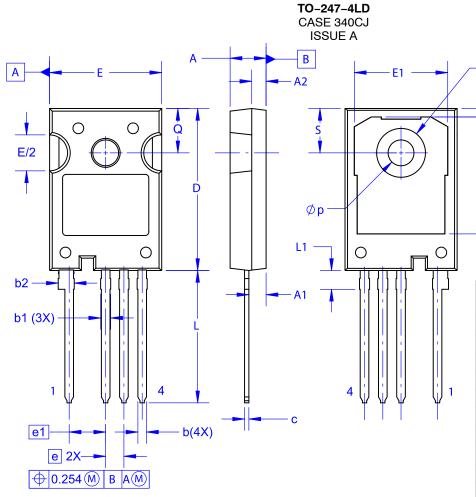


Figure 20. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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 C. ALL DIMENSIONS ARE IN MILLIMETERS.
 D. DRAWING CONFORMS TO ASME Y14.5-2009.

DIM	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	4.80	5.00	5.20	
A1	2.10	2.40	2.70	
A2	1.80	2.00	2.20	
b	1.07	1.20	1.33	
b1	1.20	1.40	1.60	
b2	2.02	2.22	2.42	
С	0.50	0.60	0.70	
D	22.34	22.54	22.74	
D1	16.00	16.25	16.50	
D2	0.97	1.17	1.37	
е	2.54 BSC			
e1	5.08 BSC			
E	15.40	15.60	15.80	
E1	12.80	13.00	13.20	
E/2	4.80	5.00	5.20	
L	18.22	18.42	18.62	
L1	2.42	2.62	2.82	
р	3.40	3.60	3.80	
p1	6.60	6.80	7.00	
Q	5.97	6.17	6.37	
S	5.97	6.17	6.37	

Øp1

D1

D2

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